

US6U37

Transistors

2.5V Drive Nch+SBD MOSFET

US6U37

●Structure

Silicon N-channel MOSFET /
Schottky barrier diode

●Features

- 1) Nch MOSFET and schottky barrier diode are put in TUMT6 package.
- 2) High-speed switching, Low On-resistance.
- 3) Low voltage drive (2.5V drive).
- 4) Built-in Low V_F schottky barrier diode.

●Applications

Switching

●Package specifications

Type	Package	Taping
	Code	TR
	Basic ordering unit (pieces)	3000
US6U37		○

●Absolute maximum ratings ($T_a=25^\circ\text{C}$)

<MOSFET>

Parameter	Symbol	Limits	Unit
Drain-source voltage	V_{DS}	30	V
Gate-source voltage	V_{GS}	± 12	V
Drain current	Continuous	I_D	± 1.5 A
	Pulsed	I_{DP}^{*1}	± 6.0 A
Source current (Body diode)	Continuous	I_S	0.6 A
	Pulsed	I_{SP}^{*1}	6.0 A
Channel temperature	T_{ch}	150	$^\circ\text{C}$
Power dissipation	P_D^{*2}	0.7	W / ELEMENT

*1 $P_w \leq 10\mu\text{s}$, Duty cycles $\leq 1\%$

*2 Mounted on a ceramic board

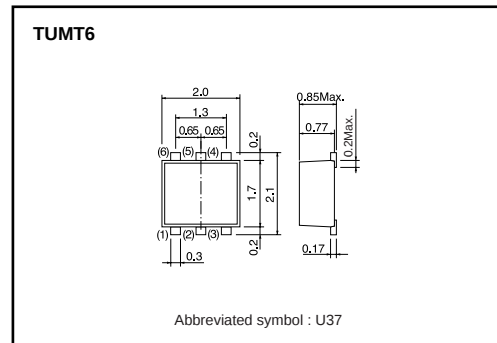
<Di>

Parameter	Symbol	Limits	Unit
Repetitive peak reverse voltage	V_{RM}	25	V
Reverse voltage	V_R	20	V
Forward current	I_F	0.7	A
Forward current surge peak	I_{FSM}^{*1}	10	A
Junction temperature	T_J	150	$^\circ\text{C}$
Power dissipation	P_D^{*2}	0.5	W / ELEMENT

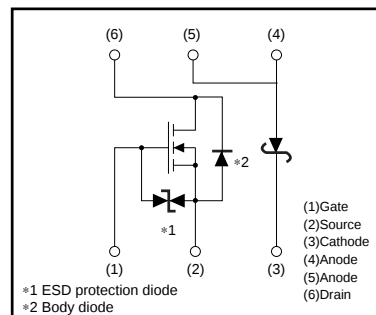
*1 60Hz · 1cycle

*2 Mounted on ceramic board

●Dimensions (Unit : mm)



●Inner circuit



US6U37

Transistors

<MOSFET and Di>

Parameter	Symbol	Limits	Unit
Power dissipation	P_D *1	1.0	W / TOTAL
Range of storage temperature	Tstg	-55 to +150	°C

*1 Mounted on a ceramic board

●Electrical characteristics (Ta=25°C)

<MOSFET>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	I_{GSS}	—	—	±10	μA	$V_{GS} = \pm 12V$, $V_{DS} = 0V$
Drain-source breakdown voltage	$V_{(BR) DSS}$	30	—	—	V	$I_D = 1mA$, $V_{GS} = 0V$
Zero gate voltage drain current	I_{DSS}	—	—	1	μA	$V_{DS} = 30V$, $V_{GS} = 0V$
Gate threshold voltage	$V_{GS(th)}$	0.5	—	1.5	V	$V_{DS} = 10V$, $I_D = 1mA$
Static drain-source on-state resistance	$R_{DS(on)}$ *	—	170	240	mΩ	$I_D = 1.5A$, $V_{GS} = 4.5V$
		—	180	250	mΩ	$I_D = 1.5A$, $V_{GS} = 4V$
		—	240	340	mΩ	$I_D = 1.5A$, $V_{GS} = 2.5V$
Forward transfer admittance	$ Y_{fs} $ *	1.5	—	—	S	$V_{DS} = 10V$, $I_D = 1.5A$
Input capacitance	C_{iss}	—	80	—	pF	$V_{DS} = 10V$
Output capacitance	C_{oss}	—	14	—	pF	$V_{GS} = 0V$
Reverse transfer capacitance	C_{rss}	—	12	—	pF	$f = 1MHz$
Turn-on delay time	$t_{d(on)}$ *	—	7	—	ns	$V_{DD} \approx 15V$ $I_D = 0.75A$
Rise time	t_r *	—	9	—	ns	$V_{GS} = 4.5V$
Turn-off delay time	$t_{d(off)}$ *	—	15	—	ns	$R_L \approx 20\Omega$
Fall time	t_f *	—	6	—	ns	$R_G = 10\Omega$
Total gate charge	Q_g *	—	1.6	2.2	nC	$V_{DD} \approx 15V$, $V_{GS} = 4.5V$
Gate-source charge	Q_{gs} *	—	0.5	—	nC	$I_D = 1.5A$
Gate-drain charge	Q_{gd} *	—	0.3	—	nC	$R_L \approx 10\Omega$, $R_G = 10\Omega$

*Pulsed

<Body diode characteristics (Source-drain)>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	V_{SD}	—	—	1.2	V	$I_S = 0.6A$, $V_{GS} = 0V$

<Di>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	V_F	—	—	0.49	V	$I_F = 0.7A$
Reverse current	I_R	—	—	200	μA	$V_R = 20V$

US6U37

Transistors

●Electrical characteristics curves

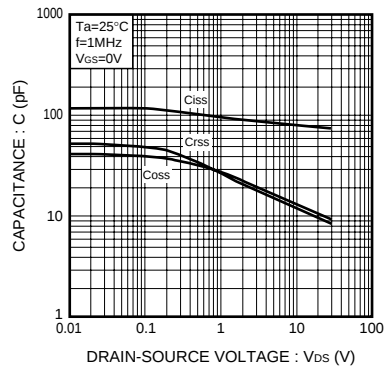


Fig.1 Typical Capacitance vs. Drain-Source Voltage

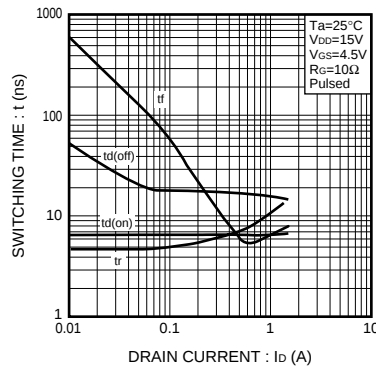


Fig.2 Switching Characteristics

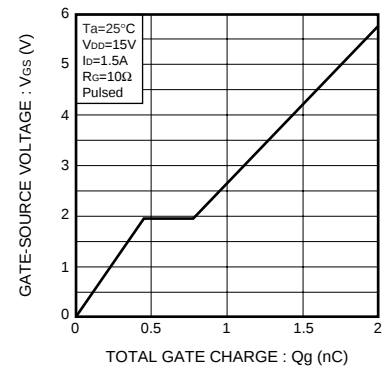


Fig.3 Dynamic Input Characteristics

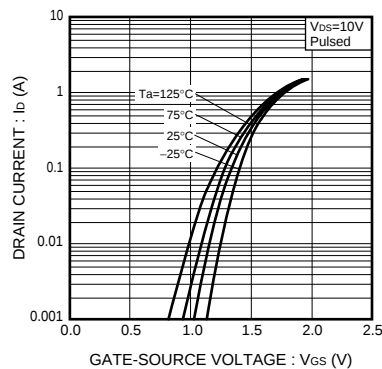


Fig.4 Typical Transfer Characteristics

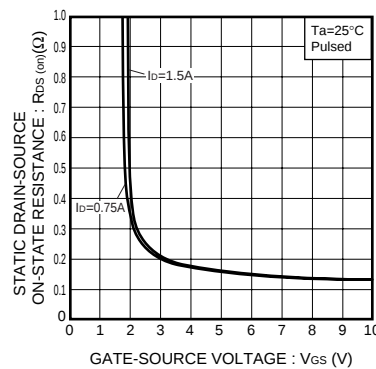


Fig.5 Static Drain-Source On-State Resistance vs. Gate source Voltage

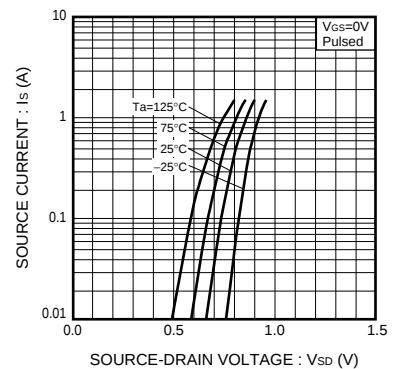


Fig.6 Source Current vs. Source-Drain Voltage

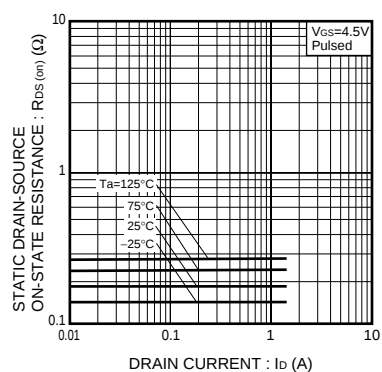


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current (I)

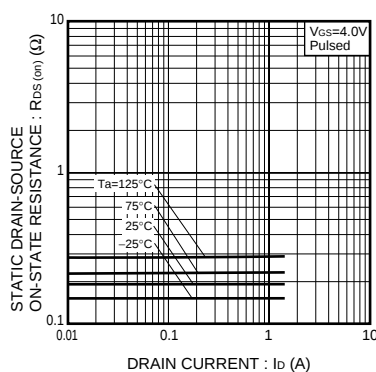


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current (II)

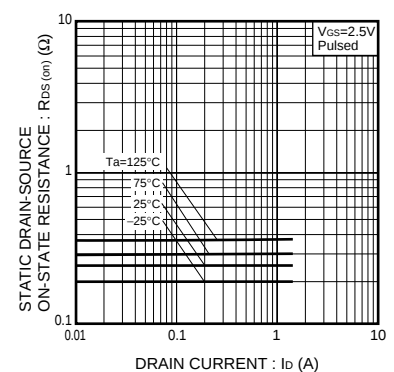


Fig.9 Static Drain-Source On-State Resistance vs. Drain Current (III)

US6U37

Transistors

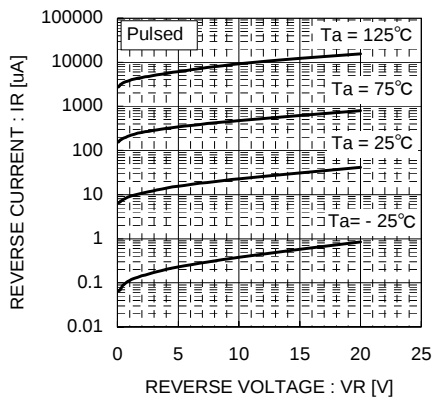


Fig.10 Reverse Current vs. Reverse

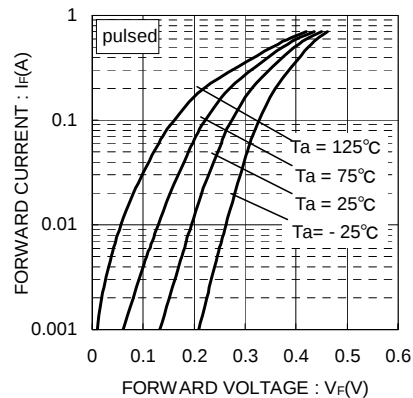


Fig.11 Forward Current vs. Forward Voltage

●Measurement circuit

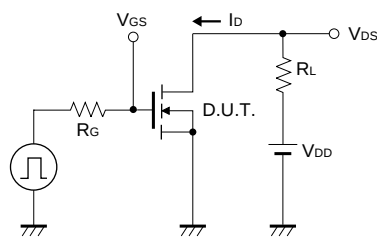


Fig.12 Switching Time Test Circuit

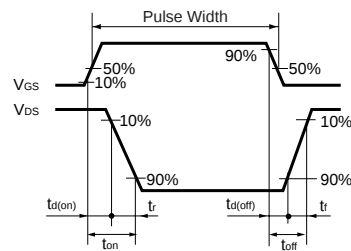


Fig.13 Switching Time Waveforms

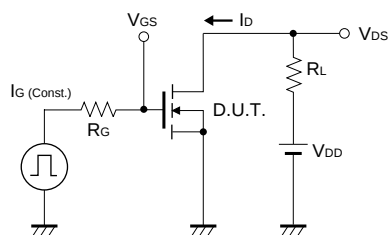


Fig.14 Gate Charge Measurement Circuit

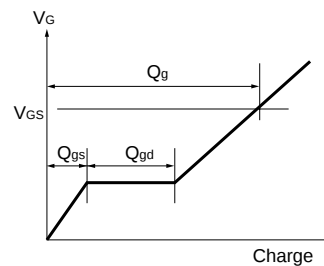


Fig.15 Gate Charge Waveform

●Notice

1. SBD has a large reverse leak current compared to other type of diode. Therefore; it would raise a junction temperature, and increase a reverse power loss. Further rise of inside temperature would cause a thermal runaway. This built-in SBD has low V_F characteristics and therefore, higher leak current. Please consider enough the surrounding temperature, generating heat of MOSFET and the reverse current.
2. This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

Appendix

Notes

- No technical content pages of this document may be reproduced in any form or transmitted by any means without prior permission of ROHM CO.,LTD.
- The contents described herein are subject to change without notice. The specifications for the product described in this document are for reference only. Upon actual use, therefore, please request that specifications to be separately delivered.
- Application circuit diagrams and circuit constants contained herein are shown as examples of standard use and operation. Please pay careful attention to the peripheral conditions when designing circuits and deciding upon circuit constants in the set.
- Any data, including, but not limited to application circuit diagrams information, described herein are intended only as illustrations of such devices and not as the specifications for such devices. ROHM CO.,LTD. disclaims any warranty that any use of such devices shall be free from infringement of any third party's intellectual property rights or other proprietary rights, and further, assumes no liability of whatsoever nature in the event of any such infringement, or arising from or connected with or related to the use of such devices.
- Upon the sale of any such devices, other than for buyer's right to use such devices itself, resell or otherwise dispose of the same, no express or implied right or license to practice or commercially exploit any intellectual property rights or other proprietary rights owned or controlled by
- ROHM CO., LTD. is granted to any such buyer.
- Products listed in this document are no antiradiation design.

The products listed in this document are designed to be used with ordinary electronic equipment or devices (such as audio visual equipment, office-automation equipment, communications devices, electrical appliances and electronic toys).

Should you intend to use these products with equipment or devices which require an extremely high level of reliability and the malfunction of which would directly endanger human life (such as medical instruments, transportation equipment, aerospace machinery, nuclear-reactor controllers, fuel controllers and other safety devices), please be sure to consult with our sales representative in advance.

It is our top priority to supply products with the utmost quality and reliability. However, there is always a chance of failure due to unexpected factors. Therefore, please take into account the derating characteristics and allow for sufficient safety features, such as extra margin, anti-flammability, and fail-safe measures when designing in order to prevent possible accidents that may result in bodily harm or fire caused by component failure. ROHM cannot be held responsible for any damages arising from the use of the products under conditions out of the range of the specifications or due to non-compliance with the NOTES specified in this catalog.

Thank you for your accessing to ROHM product informations.

More detail product informations and catalogs are available, please contact your nearest sales office.

ROHM Customer Support System

THE AMERICAS / EUROPE / ASIA / JAPAN

www.rohm.com

Contact us : webmaster@rohm.co.jp